.:	<u>ISSUE:</u> 0ct. 12
SP	ECIFICATIONS
Product Type I	Z9F Series 7000 Gates Gate Array
	2 51 Jerres 1000 Gates Gate Array
Model No.	LZ9FC23
*This specifications	
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System LSI Division Integrated Circuits Group SHARP CORPORATION

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1. Introduction

This data sheet is to introduce the specification of LZ9FC23, which is designed by Mobile Liquid Crystal Display Group Sharp Corporation, Timing Control IC for TFT-LCD module.

Applicable TFT-LCD module : QVGA (Portrait/Landscape) pixel type module

Functions: Timing Control IC for TFT-LCD module

(1) By inputting Clock signal, Horizontal sync. signal, Vertical sync. signal, the following signals synchronized with above signal are generated.

(A) The signal for driving a source driver
(B) The signal for driving a gate driver
(CLK, SPL, SPR, LP, PS
(C) The signal for creating the voltage which applies to common electrode.
(D) The signal for creating standard voltage
(C) REV
(D) The signal for creating standard voltage

(2) Horizontal and Vertical reverse scanning function

Input/Output signal timing chart for above cases

: See Fig. 1. Fig. 2. Fig. 3. Fig. 4. Fig. 5.

2. Feature

Process	:	CMOS
Wafer substrate	:	P-type silicon substrate
Package	. :	72QFP (0.5mm pin pitch)
Materials	:	Plastics
Operating Temperature	:	-30° C \sim $+85^{\circ}$ C
Propagation delay time	:	1.Ons/gate
(Condition : 2-input	NAND, Fan	out=2, wire length=2mm,
supply voltage=3.3V,	Operating	temperature Topr=25°C)

* REMARK

Not designed or rated as radiation hardened. You cannot rewrite the program.

3. Pin Assignments

Pin No.	I/0	Signal Name	Pin No.	I/0	Signal Name
1	IC	DCLK	37	O3M	CLK
2	ICU	SETR	38	-	GND
3	IC	RO	39	02M	OB5
4	IC	R1	40	02M	0B4
5	IC	R2	41	02M	OB3
6	IC	R3	42	O2M	OB2
7	IC	R4	43	O2M	0B1
8	IC	۲5 ، R5	44	02M	OBO
9	-	GND	45		V _{DD}
10	ICU	SDRSEL	46		GND
11	IC	GO	47	O2M	0G5
12	IC	G1	48	02M	0G4
13	IC	G2	49	O2M	OG3
14	IC	G3	50	02M	0G2
15	IC	G4	51	02M	0G1
16	IC	G5	52	02M	OGO
17	ICU	TEST	53	-	GND
18	IC	BO	54	02M	OR5
19	IC	B1	55	02M	OR4
20	IC	B2	56	02M	OR3
21	IC	B3	57	02M	OR2
22	IC	B4	58	02M	OR1
23	IC	B5	59	02M	ORO
24	ICU	TEST	60	-	GND
25	ICU	HREV	61	TO2M	CLS
26	ICD	ENAB	62	TO2M	SPS
27		V _{DD}	63		V _{DD}
28	_	GND	64	_	GND
29	ICU	TEST	65	TO2M	UBL
30	02M	REV	66	ICU	VREV
31	02M	REVVO	67	IC	TEST
32	02M	PS	68	IC	SIZECO
33	TO2M	SPR	69	O2M	MOD
34	02M	LBR	70	ICU	REM
35	TO2M	SPL	71	IC	HS
36	02M	LP	72	IC	VS

IC : Input buffer CMOS level

ICU :Input buffer CMOS level with PULL UP resistance (R=300k $\Omega)$

ICD \$\$:Input buffer CMOS level with PULL DOWN resistance (R=300k Ω)

02M :Output buffer (I_{0L} =0.8mA)

O3M :Output buffer (I_{0L} =1.2mA)

TO2M : Tri-state Output buffer (I_{OL}=0.8mA)

V_{DD} :Power supply pin

GND :Earth pin

4. Function of Input/Output signal

n No.	Signal Name	Explanation	I/0
1	DCLK	Input terminal for data clock signal	I
2	SETR	Input terminal for control signal for PS(Effective only in SIZECO="L")	I
	1	SETR="H" :PS signal serves as operation for specific models.	
		SETR="L" :PS signal is normal operation.	
3	RO	Input terminal for red data signal (LSB)	Ι
4	R1	Input terminal for red data signal	Ι
5	R2	Input terminal for red data signal	Ι
6	R3	Input terminal for red data signal	I
7	R4	Input terminal for red data signal	I
8	R5	Input terminal for red data signal (MSB)	Ι
9	GND	Ground	
10	SDRSEL	Input terminal for control signal for CLK and DATA output timing	Ι
		SDRSEL="H" :Normal (Effective only in SIZECO="L")	
		SDRSEL="L" :4clk delay mode	
11	GO	Input terminal for green data signal (LSB)	Ι
12	G1	Input terminal for green data signal	Ι
13	G2	Input terminal for green data signal	I
14	G3	Input terminal for green data signal	I
15	G4	Input terminal for green data signal	I
16	G5	Input terminal for green data signal (MSB)	I
17	TEST	Input terminal for test mode (Connect this terminal to "H")	I
18	BO	Input terminal for blue data signal (LSB)	I
19	B1	Input terminal for blue data signal	I
20	B2	Input terminal for blue data signal	I
21	B3	Input terminal for blue data signal	I
22	B4	Input terminal for blue data signal	I
23	B5	Input terminal for blue data signal (MSB)	I
24	TEST	Input terminal for test mode (Connect this terminal to "H")	I
25	HREV	Input terminal for setting up horizontal scan direction	I
		HREV="H" :Normal scan	
		HREV="L" :Horizontal reversal scan	
26	ENAB	Input terminal for signal to settle the Horizontal display position	I
27	V _{DD}	Input terminal for Power Supply voltage	-
28	GND	Ground	-
29	TEST	Input terminal for test mode (Connect this terminal to "H")	I
30	REV	Signal output for common electrode preparation	0
31	REVV0	Signal output for standard voltage preparation	0
32	PS	Control signal output for source driver	0
33	SPR	Start signal output for source driver	0
		When HREV="H" :SPR output is High impedance.	
		When HREV="L" :SPR output is valid.	
34	LBR	Output signal for source driver for setting up Horizontal scan direction	0
		When HREV="H", LBR="H"output.	
		When HREV="L", LBR="L"output.	
35	SPL	Start signal output for source driver	0
-		When HREV="H" :SPL outout is valid.	
		When HREV="L" :SPL outout is High impedance.	
36	LP	Data transferring signal output for source driver	0

in No.	Signal Name	Explanation	I/0
37	CLK	Clock signal output for source driver	0
38	GND	Ground	_
39	OB5	Blue data signal output for source driver (MSB)	0
40	OB4	Blue data signal output for source driver	0
41	OB3	Blue data signal output for source driver	0
42	OB2	Blue data signal output for source driver	0
43	OB1	Blue data signal output for source driver	0
44	OBO	Blue data signal output for source driver (LSB)	0
45	V _{DD}	Power Supply voltage	-
46	GND	Ground	-
47	0G5	Green data signal output for source driver (MSB)	0
48	0G4	Green data signal output for source driver	0
49	OG3	Green data signal output for source driver	0
50	0G2	Green data signal output for source driver	0
51	0G1	Green data signal output for source driver	0
52	OGO	Green data signal output for source driver (LSB)	0
53	GND	Ground	-
54	OR5	Red data signal output for source driver (MSB)	0
55	OR4	Red data signal output for source driver	0
56	OR3	Red data signal output for source driver	0
57	OR2	Red data signal output for source driver	0
58	OR1	Red data signal output for source driver	0
59	ORO	Red data signal output for source driver (LSB)	0
60	GND	Ground	
61	CLS	Clock signal output for source driver	0
62	SPS	Start signal output for gate driver	0
63	V _{DD}	Power Supply voltage	_
64	GND	Ground	
65	UBL	Output signal for gate driver for setting up Vertical scan direction When VREV="H", UBL="H"output When VREV="L", UBL="L"output	0
66	VREV	Input terminal for setting up vertical scan direction VREV="H" :Normal scan VREV="L" :Vertical reversal scan	I
67	TEST	Input terminal for test mode (Connect this terminal to "L")	I
68	SIZECO	Input terminal for setting up display resolution	I
		SIZECO="H" :Portrait QVGA(240RGB×320)	
		SIZECO="L" :Landscape QVGA(320RGB×240)	
69	MOD	Output signal for gate driver	0
70	REM	Input terminal for reset signal (Give the signal that becomes H level fixation from the L level at the time of the power supply input.)	I
71	HS	Input terminal for Horizontal sync. signal	I
72	VS	Input terminal for Vertical sync. signal	T

5. Absolute Maximum Ratings

· · · · · · · · · · · · · · · · · · ·			
Parameter	Symbol	Rating	Unit
Supply voltage	V _{DD}	$-0.3 \sim +6.0$	V
Input voltage	VI	$-0.3 \sim V_{DD} + 0.3$	V
Output voltage	V ₀	$-0.3 \sim V_{DD} + 0.3$	V
Operating temperature	Topr	$-30 \sim +85$	°C
Storage temperature	Tstg	$-55 \sim +150$	°C

6. Electrical Specifications

6-1. Operating Conditions

0 1. Operating condi	10113				
Parameter	Symbol	MIN.	TYP.	MAX.	Unit
Supply voltage	V _{DD}	+2.7	+3.3	+3.6	V
Operating temperature	Topr	-30		+85	°C

6-2. Electrical Characteristics

 $(V_{DD} = +2.7 \sim +3.6V, T_{OD} = -30 \sim +85^{\circ}C)$

					1012 00		
Parameter	Symbol	Test conditions	MIN.	TYP.	MAX.	Unit	#
Input"Low" voltage	VIL				0.3 \times V _{DD}	V	
Input"High"voltage	V _{IH}		0.7 \times V _{DD}			V	1
Input"High"current	I IH1	$V_I = V_{DD}$			1.0	μΑ	
Input"Low" current	I _{IL1}	$V_I = 0 V$			1.0	μ Α	2
Input"High"current	I _{1H2}	$V_{I} = V_{DD}$			1.0	μΑ	
Input"Low" current	I _{IL2}	$V_I = 0 V$	2.0		36.0	μΑ	3
Input"High"current	I _{IH3}	$V_I = V_{DD}$	2.0		36.0	μ Α	
Input"Low" current	I _{IL3}	$V_I = 0 V$			1.0	μ Α	4
Output"Low" voltage	V _{0L1}	$I_{0L} = 0.8 \text{mA}$			0.4	V	
Output"High"voltage	V _{OH1}	$I_{OH} = -0.4 \text{mA}$	V _{DD} -0.5			V	5
Output"Low" voltage	V _{0L2}	$I_{0L} = 1.2 \text{mA}$			0.4	V	
Output"High"voltage	V _{0H2}	$I_{0H} = -0.6 \text{mA}$	V _{DD} -0.5			V	6
Output Leakage Current	I _{OZ}	High-impedance state			1.0	μΑ	7

#1: Applied to Input pins (IC, ICU, ICD).
#2: Applied to Input pins (IC).
#3: Applied to Input pins (ICU).
#4: Applied to Input pin (ICD).
#5: Applied to Output pins (O2M, TO2M).
#6: Applied to Output pin (O3M).
#7: Applied to Output pins (TO2M).

7. Timing Characteristics of Input/Output Signals

Input Timing Characteristics

(1) IUILIAIL WYGA (240NGDX320	1.312ECO-1	1		
Parameter	Symbol	Min.	Тур.	Max.	Unit
DCLK frequency	f _{DCLK}	4.5		6.8	MHz
HS frequency	f _{HS}	$f_{\text{DCLK}}/330$		$f_{\text{DCLK}}/254$	kHz
		15		26	kHz
VS frequency	f _{vs}	f _{HS} /440		f _{HS} /332	Hz
		50		80	Hz

(1) Portrait QVGA (240RGBx320):SIZECO="H"

(2) Landscape QVGA (320RGBx240):SIZECO="L"

	(on orconing T	- /	-		
Parameter	Symbol	Min.	Typ.	Max.	Unit
DCLK frequency	f _{dclk}	4.5		6.8	MHz
HS frequency	f_{HS}	$f_{\text{DCLK}}/440$		$f_{\rm DCLK}/334$	kHz
		12.5		20	kHz
VS frequency	f _{vs}	$f_{\rm HS}/330$		$f_{\rm HS}/248$	Hz
	<u> </u>	50		82	Hz







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9	Package and packing specification
	[Applicability]
	This specification applies to IC package of the LEAD-FREE delivered as a standard specification.
	1.Storage Conditions.
	1-1. Storage conditions required before opening the dry packing.
	• Normal temperature : $5 \sim 40^{\circ}$ C
	• Normal humidity : 80% (Relative humidity) max.
	"Humidity" means "Relative humidity"
	1-2. Storage conditions required after opening the dry packing.
	In order to prevent moisture absorption after opening, ensure the following storage
	conditions apply:
	(1) Storage conditions for one-time soldering. (Convection reflow ^{*1} , IR/Convection reflow. ^{*1} ,
	or Manual soldering.)
	• Temperature : $5 \sim 25^{\circ}$ C
	• Humidity : 60% max.
	• Period : 168 hours max. after opening.
	(2) Storage conditions for two-time soldering. (Convection reflow ^{*1} , IR/Convection reflow. ^{*1})
	a. Storage conditions following opening and prior to performing the 1st reflow.
	• Temperature : $5 \sim 25^{\circ}$ C
	• Humidity : 60% max.
	• Period : 96 hours max. after opening.
	b. Storage conditions following completion of the 1st reflow and prior to performing
	the 2nd reflow.
•	• Temperature : $5 \sim 25^{\circ}$ C
	• Humidity : 60% max.
	• Period : 96 hours max. after completion of the 1st reflow.
	^{*1} :Air or nitrogen environment.
	1-3. Temporary storage after opening.
	To re-store the devices before soldering, do so only once and use a dry box or place desiccant
	(with a blue humidity indicator) with the devices and perform dry packing again using
	heat-sealing.
	The storage period, temperature and humidity must be as follows :
	(1) Storage temperature and humidity.
	%1: External atmosphere temperature and humidity of the dry packing.
	Rivet evening
	First opening 4 X1 \longrightarrow Re-sealing 4 Y \longrightarrow Re-opening 4 X2 \longrightarrow Mounting
	$(1 \text{ Temperature}: 5 \sim 40^\circ \text{C})$ $5 \sim 25^\circ \text{C}$ $\% 1 5 \sim 40^\circ \text{C}$ $5 \sim 25^\circ \text{C}$
I	lumidity : 80% max. 60% max. 60% max.
	(2) Storage period.
	• $X1 + X2$: Refer to Section 1-2(1) and (2)a, depending on the mounting method.
	• Y : Two weeks max.

- 2. Baking Condition.
 - (1) Situations requiring baking before mounting.
 - Storage conditions exceed the limits specified in Section 1-2 or 1-3.
 - · Humidity indicator in the desiccant was already red (pink) when opened.
 - (Also for re-opening.)
 - (2) Recommended baking conditions.
 - Baking temperature and period :
 - 120°C for 16~24 hours.
 - The above baking conditions apply since the trays are heat-resistant.
 - (3) Storage after baking.
 - After baking, store the devices in the environment specified in Section 1-2 and mount immediately.
- 3. Surface mount conditions.

The following soldering condition are recommended to ensure device quality.

- 3-1.Soldering.
- (1) Convection reflow or IR/Convection. (one-time soldering or two-time soldering in air or nitrogen environment)
 - · Temperature and period :
 - A) Peak temperature.
 - B) Heating temperature.
 - C) Preheat temperature.
 - D) Temperature increase rate.
 - Measuring point : IC package surface.
 - Temperature profile:

250℃ max. 40 to 60 seconds as 220℃ It is 150 to 200℃, and is 120±30 seconds It is 1 to 3℃/seconds



- Manual soldering (soldering iron) (one-time soldering only)
 Soldering iron should only touch the IC's outer leads.
 - Temperature and period :
 - 350°C max. for 3 seconds / pin max.
 - (Soldering iron should only touch the IC's outer leads.)
 - Measuring point : Soldering iron tip.

4. Condition for removal of residual flux.

- (1) Ultrasonic washing power : 25 watts / liter max.
- (2) Washing time : Total 1 minute max.
- (3) Solvent temperature : $15 \sim 40^{\circ}$ C

5. Package outline specification.

Refer to the attached drawing.

(Plastic body dimensions do not include burr of resin.)

The contents of LEAD-FREE TYPE application of the specifications. (*2)

6. Markings.

6-1. Marking details. (The information on the package should be given as follows.)

- (1) Product name : LZ9FC23
- (2) Company name : SHARP
- (3) Date code : (Example) YYWW XXX YY \rightarrow Denotes the production year. (Last two digits of the year.) WW \rightarrow Denotes the production week. (01 \cdot 02 $\cdot \sim \cdot$ 52 \cdot 53) XXX \rightarrow Denotes the production ref. code (1~3 digits).
- (4) "JAPAN" indicates the country of origin.

6-2.Marking layout.

The layout is shown in the attached drawing.

(However, this layout does not specify the size of the marking character and marking position.)

LEAD FINISH or BALL TYPE	LEAD-FREE TYPE (Sn-Bi)	
DATE CODE	They are those with an underline.	
The word of "LEAD FREE" is printed on the packing label	Printed	

*2 The contents of LEAD-FREE TYPE application of the specifications.



7.Packing Specifications (Dry packing for surface mount packages.) 7-1.Packing materials.

Material name	Material specifications	Purpose
Inner carton	Cardboard (800 devices / inner carton max.)	Packing the devices. (10 trays / inner carton)
Tray	Conductive plastic (80 devices / tray)	Securing the devices.
Upper cover tray	Conductive plastic (1 tray / inner carton)	Securing the devices.
Laminated aluminum bag	Aluminum polyethylene	Keeping the devices dry.
Desiccant	Silica gel	Keeping the devices dry.
Label	Paper	Indicates part number, quantity, and packed date.
PP band	Polypropylene (3 pcs. / inner carton)	Securing the devices.
Outer carton	Cardboard (3200 devices / outer carton max.)	Outer packing.

(Devices must be placed on the tray in the same direction.)

7-2.Outline dimension of tray.

Refer to the attached drawing.

7-3. Outline dimension of carton.

Refer to the attached drawing.

8. Precautions for use.

- (1) Opening must be done on an anti-ESD treated workbench. All workers must also have undergone anti-ESD treatment.
- (2) The trays have undergone either conductive or anti-ESD treatment. If another tray is used, make sure it has also undergone conductive or anti-ESD treatment.
- (3) The devices should be mounted within one year of the date of delivery.





Inner carton





